

The STA offers a valuable time reduction and greatly reduces the risk of damaging the probe tip and the sample when approaching a region of interest.

Your existing micromanipulator system can be quickly and easily upgraded for use with the STA.

Applications

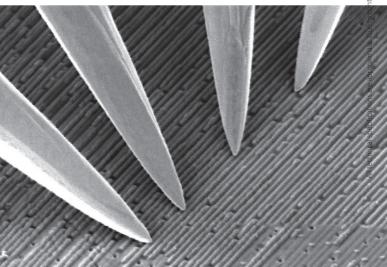
- Failure analysis
- Low-current transistor measurement
- EBIC/RCI analysis
- Electrical characterization of advanced materials e.g. nanowires, ultra-thin films

Technical specifications

- Tip voltage range -10 to +10 V
- Current threshold 100 nA

Further information

- Contact us at info@kleindiek.com
- Find your local agent at www.kleindiek.com





ocntinuous development, we reserve the right to change specifications without notice. Version 8.10. © Kleindiek Nanotechnik GmbH.